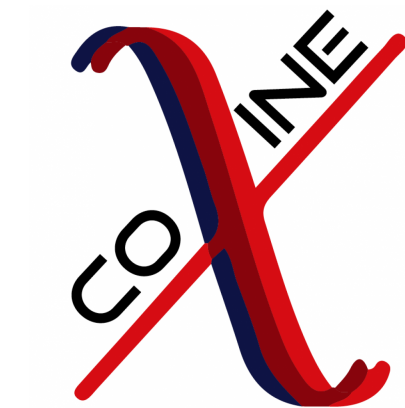
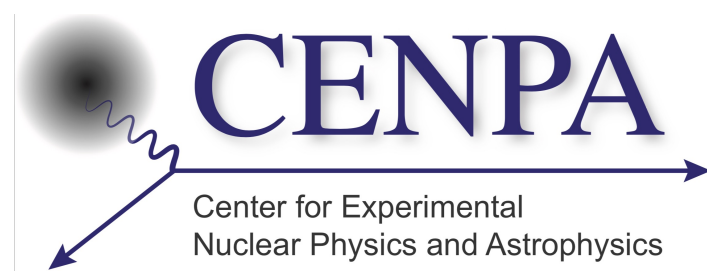


INSS 2026 Stats Presentation: How To Work As A Group And Basic NLL

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INSS Stat Group VI, Santa Barbara, CA

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Università
di Catania



Working as group:

A **Turk**, A **Korean** and **two Italians** walk into a bar...
you complete the joke

But on a 5 sigma level its related to stats

Approach to the project:

- *Silent reading* of the problems for the first 20 minutes.
- Deciding what kind of a presentation we want:
 - A. Do all of the questions by splitting
 - B. Focus on each question and have detailed answers even if don't have time to present all.

Maximizing Success Likelihood (Minimizing failure log likelihood)

Utility / “Learning Impact” Model

$$\mathcal{U}(n) = \frac{D(n)^\alpha I(n)^\beta A(n)^\gamma C}{n^\delta}$$

where

- n** = number of questions we tackle (out of 5)
- D** = depth of discussion per question
- I** = individual understanding gained
- A** = audience learning during presentation
- C** = collaboration efficiency (team synergy)
- $\alpha, \beta, \gamma, \delta > 0$ are weights reflecting our priorities

Key assumption (fixed total time T and opportunity):

When we spread over more questions, the depth, understanding and audience impact per question are diluted.

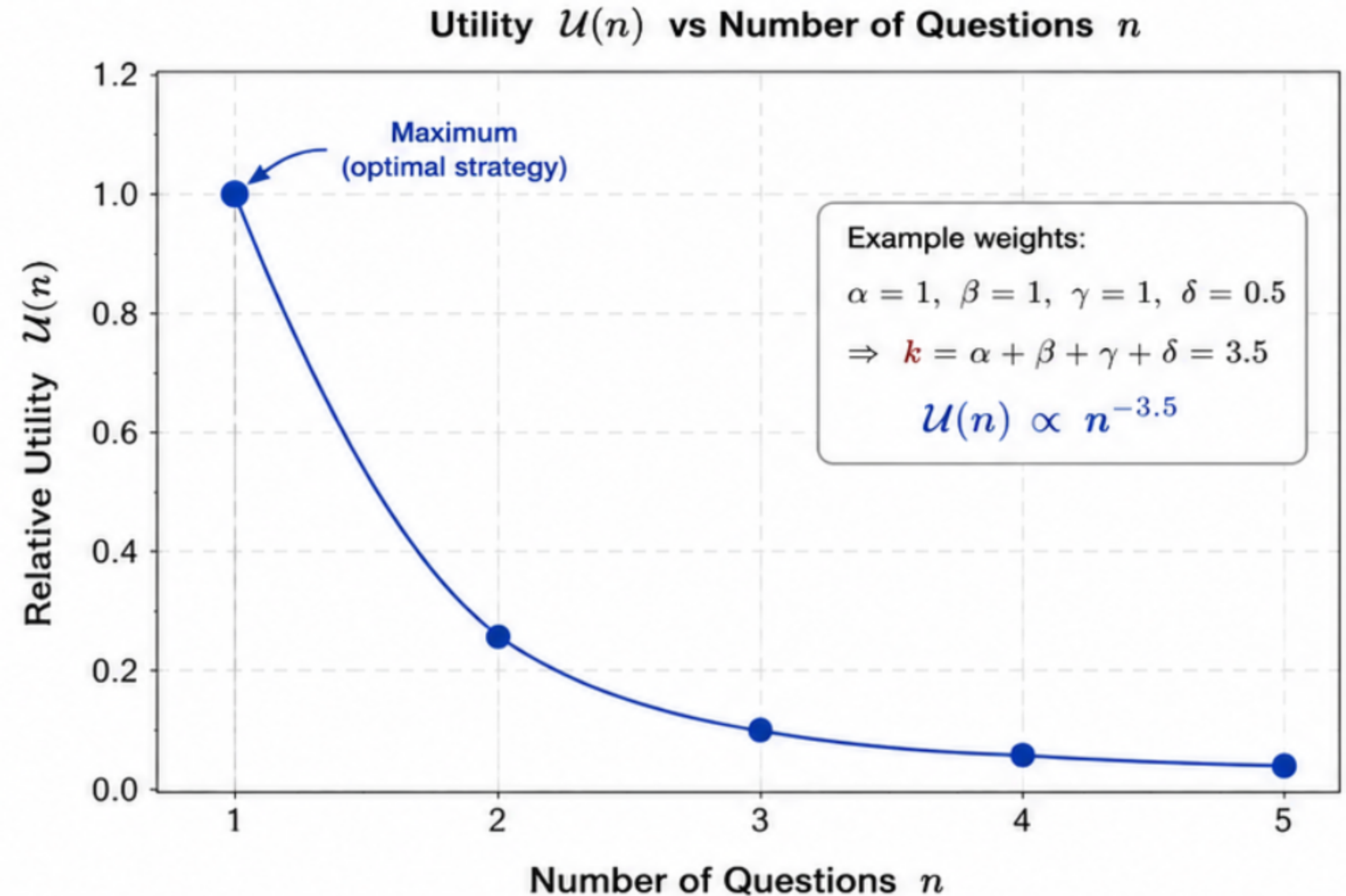
We model this as

$$D(n) \propto n^{-1}, \quad I(n) \propto n^{-1}, \quad A(n) \propto n^{-1}$$

Therefore,

$$\mathcal{U}(n) \propto \frac{C}{n^{\alpha+\beta+\gamma+\delta}} \equiv \frac{C}{n^k} \quad (k > 0)$$

which is maximized for the smallest possible n .



Exercise I

Exercise 1

A physics analysis with a large background B seeks to extract a signal S from an extended likelihood $S + B$ fit to a multivariate discriminant. The binned PDFs for signal and background, as well as the data distributions are shown in Fig. 1. The histograms of Fig. 1 can be downloaded in ROOT or npz format from

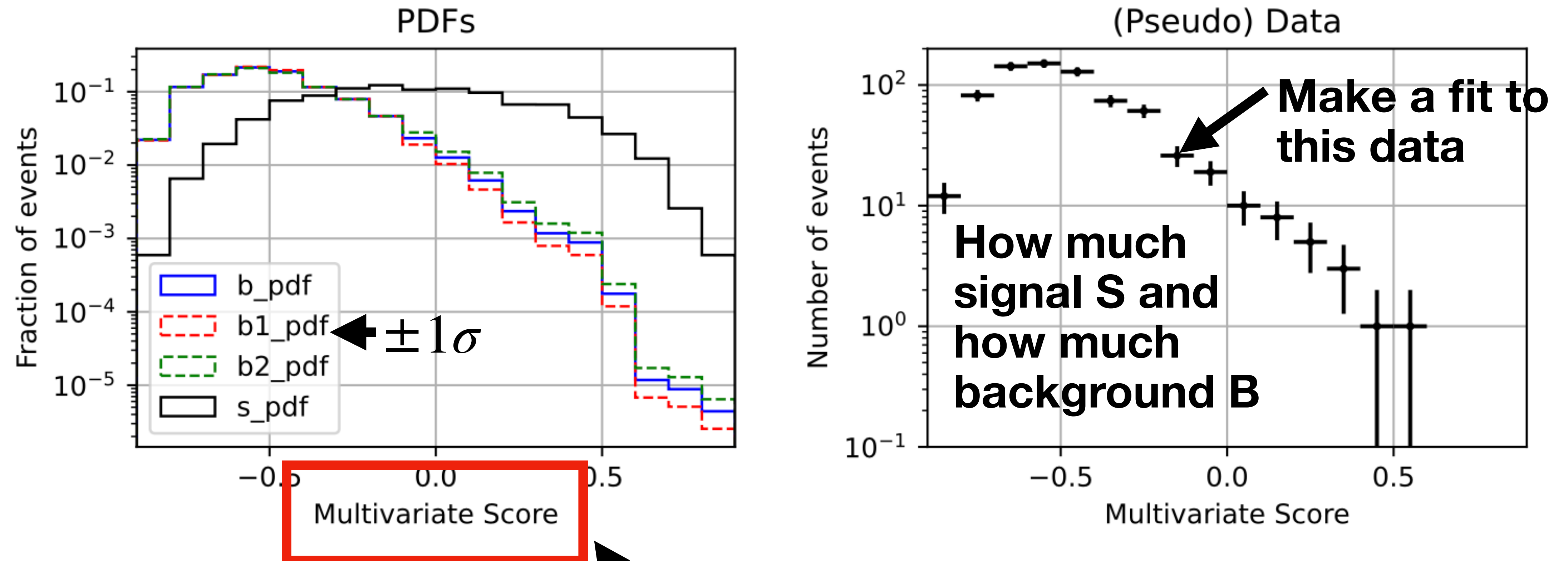


Figure 1: Left: signal and background PDFs (b_pdf is the background PDF, $b1_pdf$ and $b2_pdf$ represent the $\pm 1\sigma$ variations. Right: data) classification between background and signal

Step 1: What is the data

- It is a **binned** data. For each i , the observed data are:
 d_i = number of observed events in bin i .
- The object we fit is not one number. It is the full list of bin counts:
 $(d_1, d_2, \dots, d_N)$.
- These are event counts, the natural statistical model is a Poisson model. If the model predicts an expected number of events μ_i in bin i
$$P(d_i \mid \mu_i) = \frac{\mu_i^{d_i} e^{-\mu_i}}{d_i!}.$$
- The fit changes the model parameters until the predicted bin counts μ_i make the observed counts d_i as likely as possible.

Question For The Audience:

- The models show **fractions of events across bins**.

Normalized $\sum_i s_i = 1, \quad \sum_i b_i = 1.$

- If the total number of signal events is S , then the expected signal count in bin i is Ss_i .
- If the total number of background events is B , then the expected background count in bin i is Bb_i .
- Total expected count $\mu_i(S, B) = Ss_i + Bb_i$.
- **Two questions possible:**
 1. Given that we observed exactly **N** events, what fraction of them look **signal-like** versus **background-like**?
 2. What total number of signal and background events best explains both the **shape** and the **total event count**?

Building The Likelihood

- The full binned likelihood is the product over bins: $L(S, B) = \prod_i P(d_i \mid \mu_i(S, B))$
- Equivalently: $L(S, B) = \prod_i \frac{\mu_i(S, B)^{d_i} e^{-\mu_i(S, B)}}{d_i!}$.
- The negative log-likelihood, dropping constants that do not depend on S or B , is $\text{NLL}(S, B) = \sum_i [\mu_i(S, B) - d_i \ln \mu_i(S, B)]$.
- **This is what we minimize!**
- We all like to see familiar things :)
- For large counts expanding around $\mu_i \approx d_i$ gives approximately
$$\text{NLL} \approx \text{constant} + \frac{1}{2} \sum_i \frac{(d_i - \mu_i)^2}{\mu_i}$$
- **This is the chi square!**

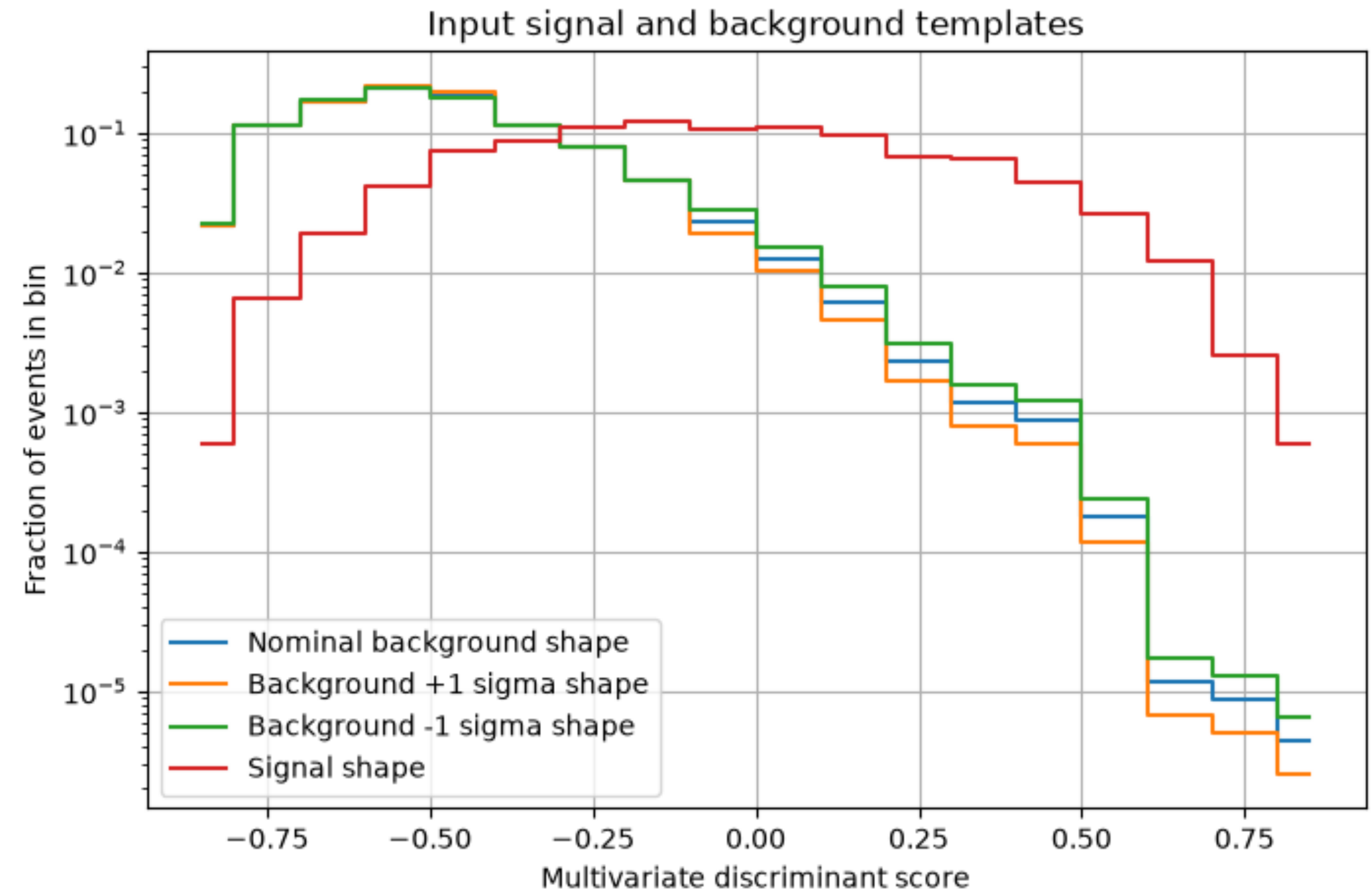
Now Fitting **Level I**: Background has no uncertainty



- The model would only need the yields S and B : $\mu_i(S, B) = Ss_i + Bb_i$.
- We ask: For each possible pair (S, B) , how likely is it that Poisson fluctuations around $\mu_i(S, B)$ would have produced the observed counts d_i ?
- The best fit is the pair $(\hat{S}, \hat{B})$ that makes this likelihood largest, or equivalently makes the NLL smallest
- Clean!

Fitting **Level II**: Background has known uncertainty

- We introduce a nuisance parameter α :
- $\alpha = 0$: use the nominal background shape.
- $\alpha = 1$: use the $+1\sigma$ shifted background shape.
- $\alpha = -1$: use the -1σ shifted background shape.
- Morphing idea from Stats Lecture, slide 9.



- The model becomes $\mu_i(S, B, \alpha) = Ss_i + Bb_i(\alpha)$.
- The likelihood becomes $L(S, B, \alpha) = \left[\prod_i \frac{\mu_i(S, B)^{d_i} e^{-\mu_i(S, B)}}{d_i!} \right] \cdot e^{-\frac{\alpha^2}{2}}$.
- The constrained NLL is therefore $\text{NLL}(S, B, \alpha) = \sum_i [\mu_i - d_i \ln \mu_i] + \frac{\alpha^2}{2}$.

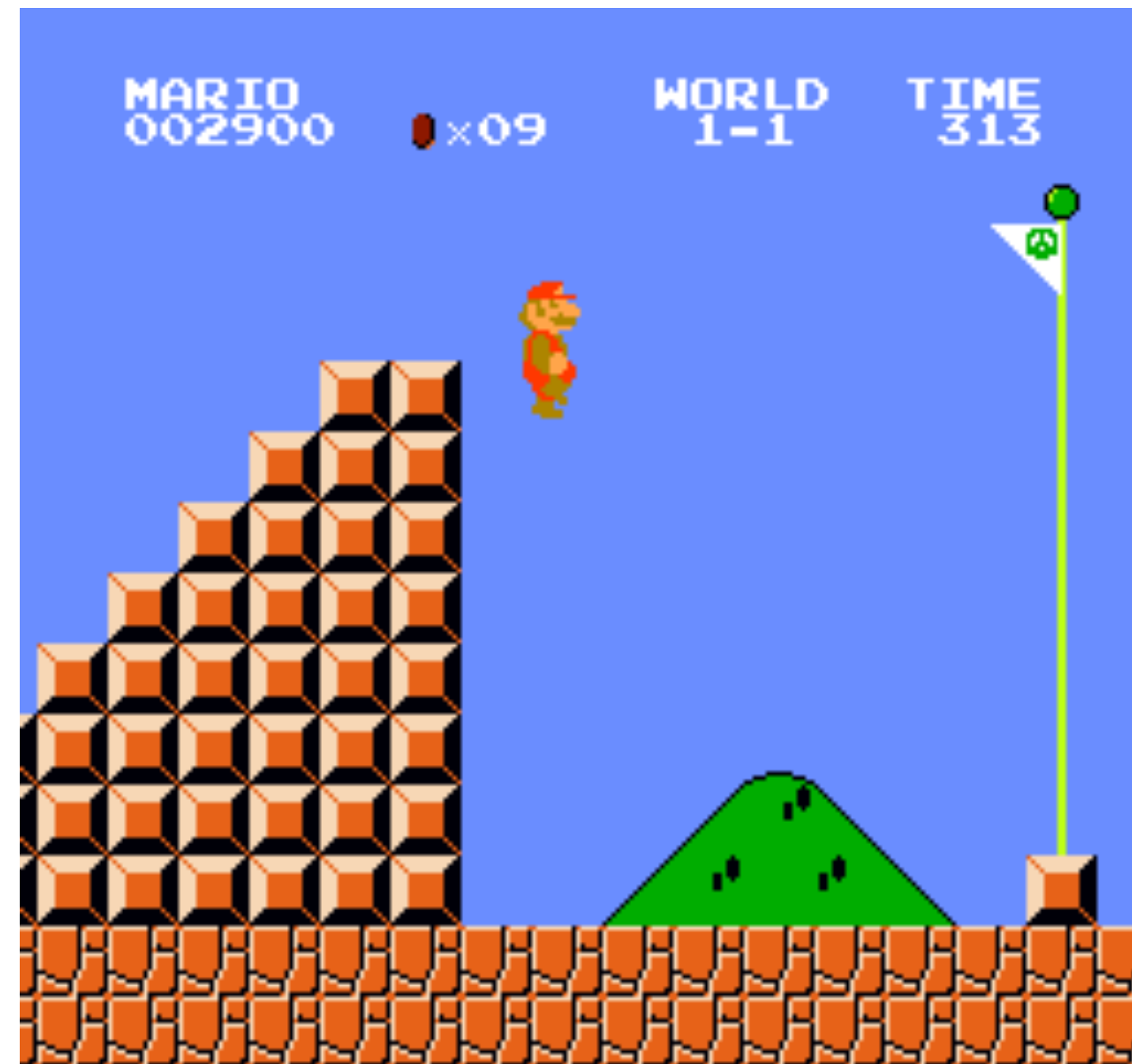


Questions For Thought Before Results

- What if we did not know 1 sigma uncertainty exactly?
 - Possibly a bayesian MCMC where we model the background as a fixed parameter plus a gaussian.
 - Both the mean and standard deviation of the gaussian would be parameters themselves who would be distributed as a gaussian.
 - But what if the parameters of the gaussian are not gaussian distributed? What if standard deviations are not symmetric?

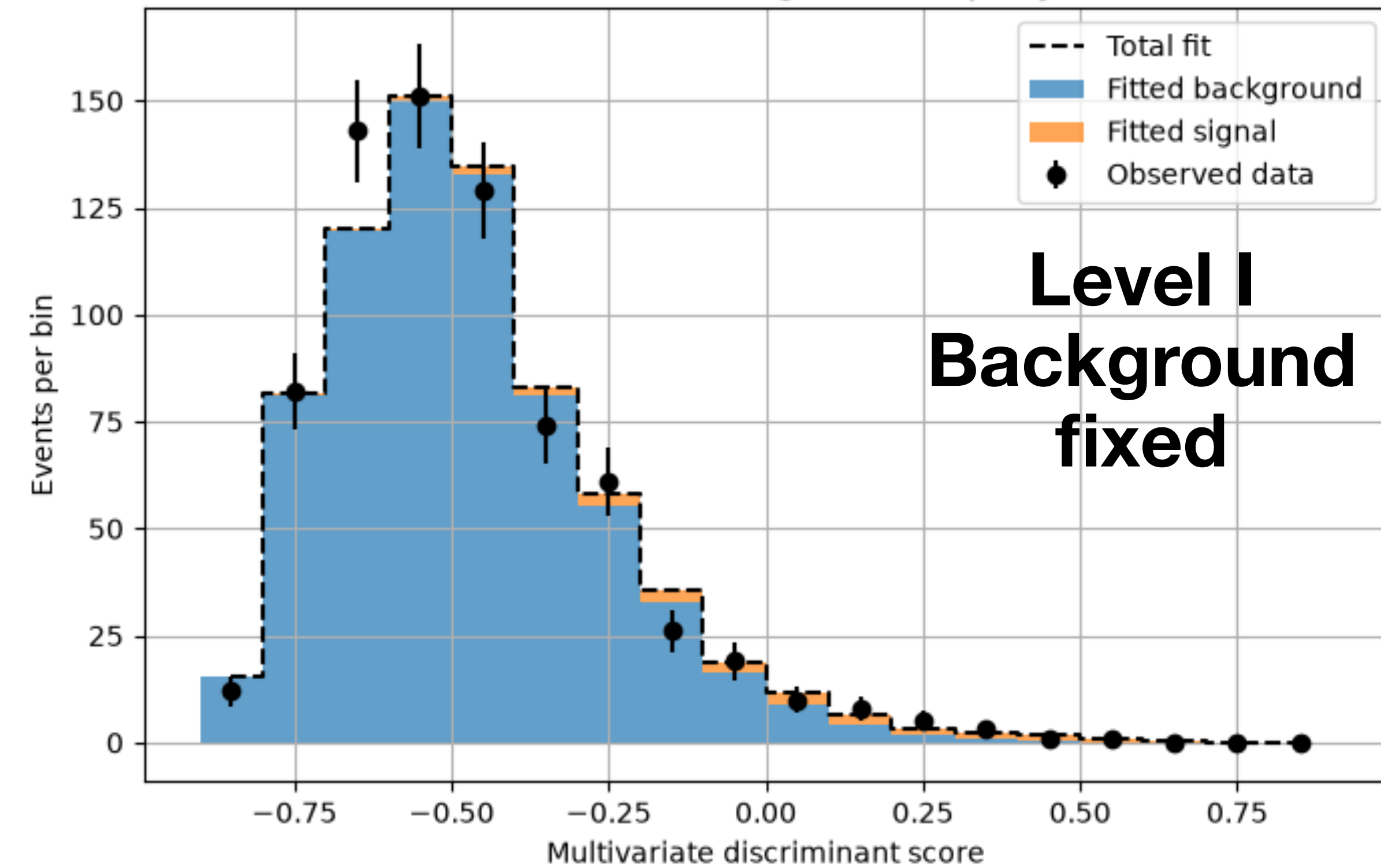


Actual Results For **Level I** and **II** Fitting



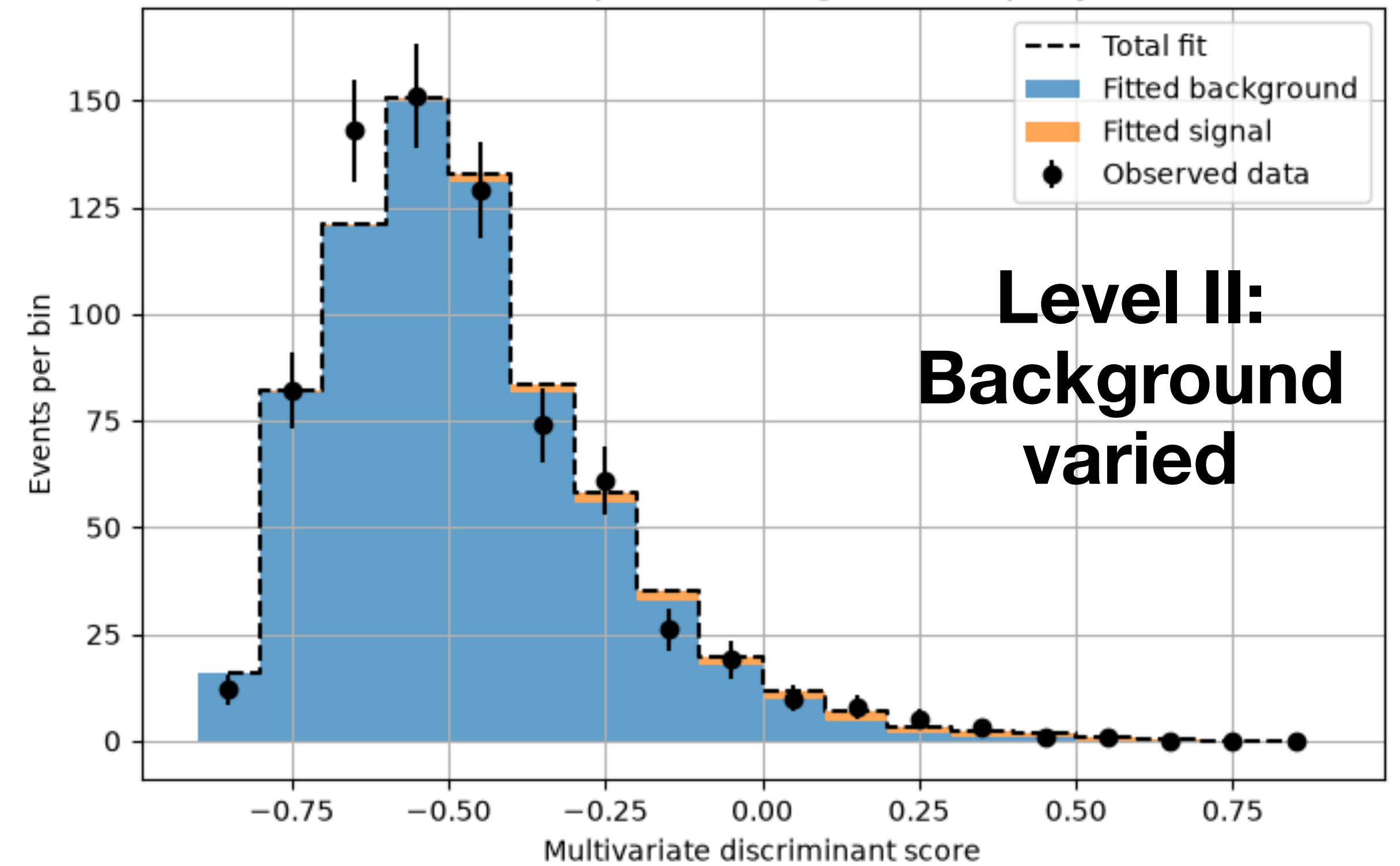
Actual Results For **Level I** and **II** Fitting

Exercise 1 fit without background shape systematic



- $\hat{S} = 23.506$ events; $\hat{B} = 701.508$ events
- $NLL_{min} = -2515.384$

Exercise 1 fit with profiled background shape systematic



- $\hat{S} = 20.013$ events; $\hat{B} = 705.000$ events
- $NLL_{min} = -2515.537$ ← **Better**

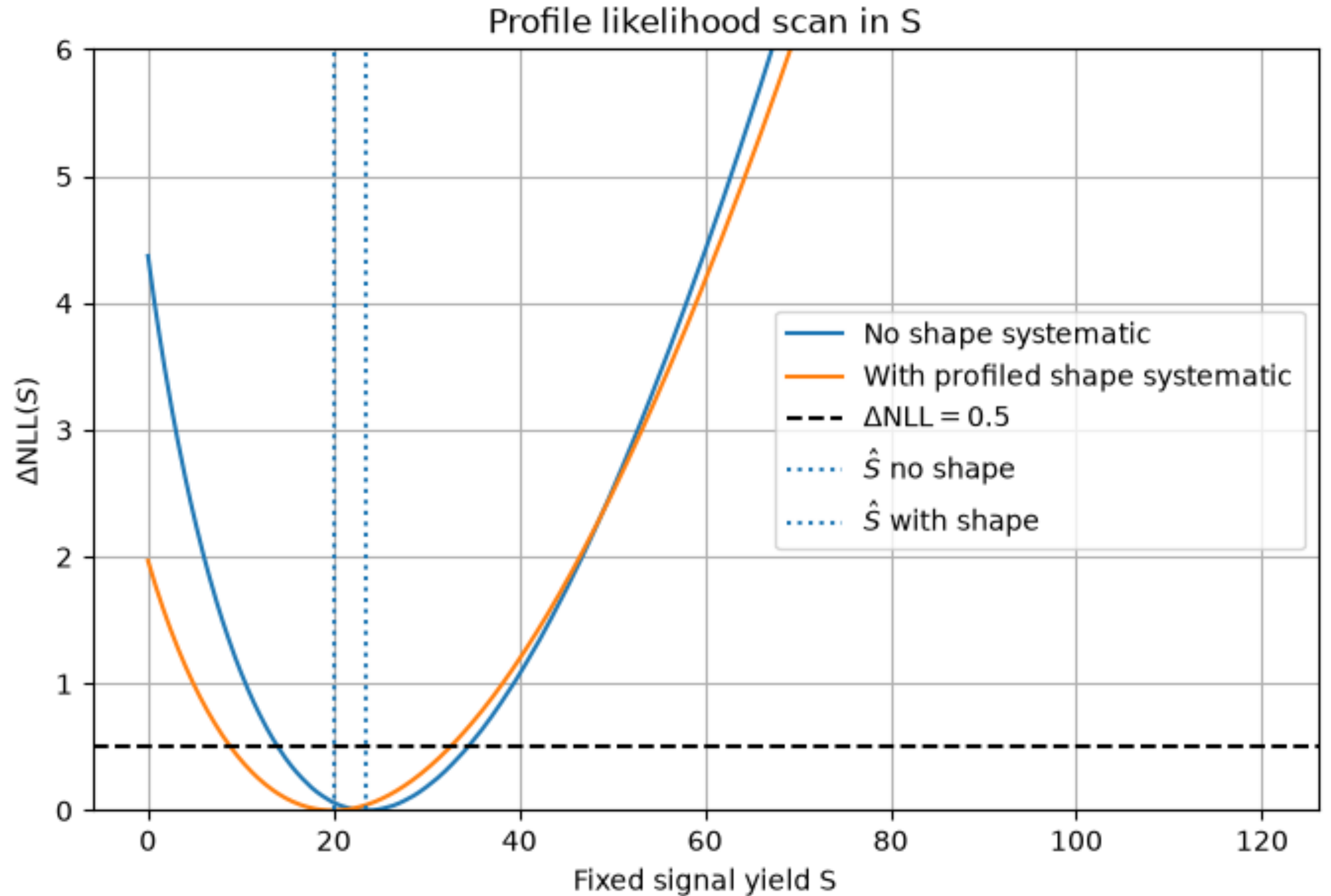
Wait!! Where are the uncertainties of these values????

Profile Likelihood Scan Uncertainties and $\Delta\text{NLL} = 0.5$

- The full fit gives one best-fit value $\hat{S}$. To get the uncertainty on S , we scan possible fixed values of S .
- If I force the signal yield to be this value, what background normalization B and background-shape shift α make the fit as good as possible
- For each fixed S , we refit the nuisance parameters:
 - Without shape systematic: refit B .
 - With shape systematic: refit B and α .
- This gives the profile $\text{NLL}_{\text{profile}}(S) = \min_{B, \alpha} \text{NLL}(S, B, \alpha)$
- Then we plot $\Delta\text{NLL}(S) = \text{NLL}_{\text{profile}}(S) - \text{NLL}_{\text{min}}$.
- The approximate one-standard-deviation interval for one parameter is where $\Delta\text{NLL} = 0.5$

Final Results

- Without shape systematic:
 $S = 23.51^{+10.94}_{-9.50}$
events.
- With shape systematic:
 $S = 20.01^{+12.52}_{-11.11}$
events.



Quick Recap

- We gave a detailed solution to a NLL fit exercise.
- We thought just talking about solutions would not be very productive. But here are they if people need it https://github.com/alikurmus/INSS_2026.
- ROOT-based solution of exercise 1: https://github.com/TFTmaster/INSS2026_stats
- Learning to work as a group was as important.
- We have other suggestions that are useful.

Best Practices For Collaboration

- Use GitHub/ or any version control you like.
- DO NOT COMMIT ON MAIN
- PLEASE PR
- DO NOT `git add -a`
- Package when possible.

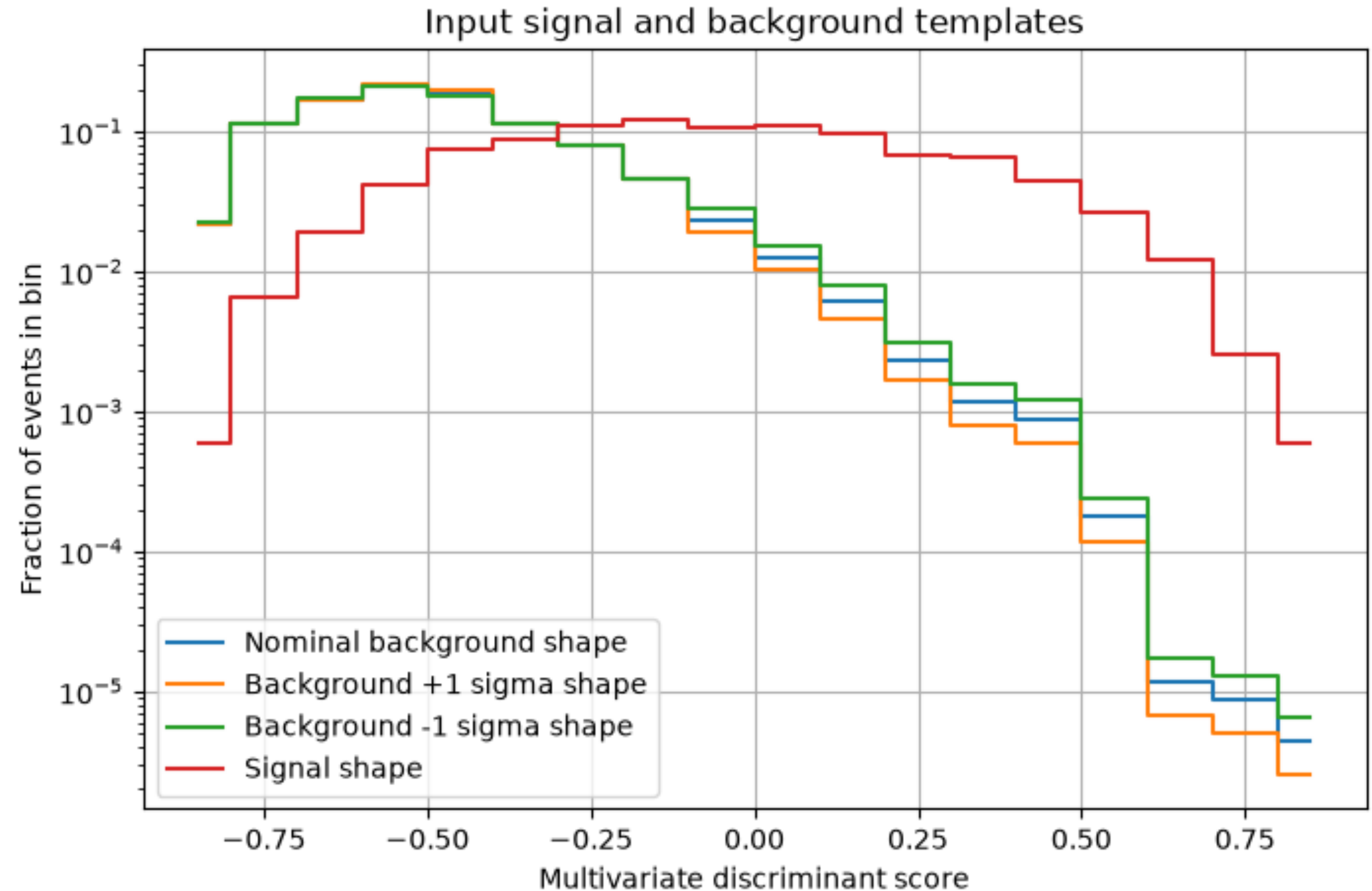
Thank You For Your Time



Backup

Fitting Level II: Background has known uncertainty

- We introduce a nuisance parameter α :
- $\alpha = 0$: use the nominal background shape.
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- $\alpha = -1$: use the -1σ shifted background shape.
- Morphing idea from Stats Lecture, slide 9.



- The model becomes $\mu_i(S, B, \alpha) = Ss_i + Bb_i(\alpha)$.
- We penalize large values with a Gaussian constraint $\frac{\alpha^2}{2} \Rightarrow \alpha \sim \mathcal{N}(0,1)$
- The constrained NLL is therefore
$$\text{NLL}(S, B, \alpha) = \sum_i [\mu_i - d_i \ln \mu_i] + \frac{\alpha^2}{2}.$$